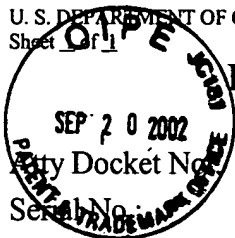


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Sheet 1 of 1

PATENT AND TRADEMARK OFFICE



LIST OF REFERENCES CITED BY APPLICANT

Patent Docket No.

5054-6PUS

Filing Date: 08 February 2002

Serial No.

10/049,314

Group Art: Not Yet Assigned

Applicant:

Johannes VÄÄNÄNEN

U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
<i>RLO</i>	AA	5,602,566	02/1997	Motosyuku et al.			
	AB						
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
<i>RLO</i>	AF	WO 99/22338	05/1998	WIPO				
<i>RLO</i>	AG	WO 99/32960	07/1999	WIPO				
<i>RLO</i>	AH	10011249	01/1998	EPO				Yes
<i>RLO</i>	AI	2000259856	09/2000	EPO				Yes
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AK		
	AL		
	AM		

EXAMINER:

Ricardo Garcia

DATE CONSIDERED:

11/15/03

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Sheet 1 of 1

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LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No.: 5054-6PUS Filing Date: 08 February 2002
Serial No.: 10/049,314 Group Art: Not Yet Assigned
Applicant: Johannes VÄÄNÄNEN

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*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
RLO	AA	5,675,361	10/1997	Santilli			
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	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER: *Richard O'Hara*

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LIST OF REFERENCES CITED BY APPLICANT

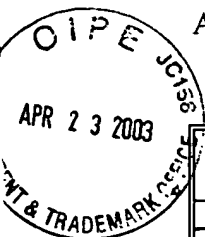
Atty Docket No.: 5054-6PUS

Filing Date: February 08, 2002

Serial No.: 10/049,314

Group Art: 2835

Applicant: Johannes VÄÄNÄNEN



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	AA	5,602,566	02/1997	Motosyuku et al.			
RLO	AB	6,201,554	03/2001	Lands			
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RLO	AF	WO 98/14863	04/1998	WIPO				
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	AI							
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AK		
	AL		
	AM		

EXAMINER: *Richard D. Davis*

DATE CONSIDERED:

11/14/03

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